

TD62164APG,TD62164AFG

4ch High-Current Darlington Sink Driver

The TD62164APG and TD62164AFG are high-voltage, high-current darlington drivers comprised of four NPN darlington pairs.

All units feature integral clamp diodes for switching inductive loads.

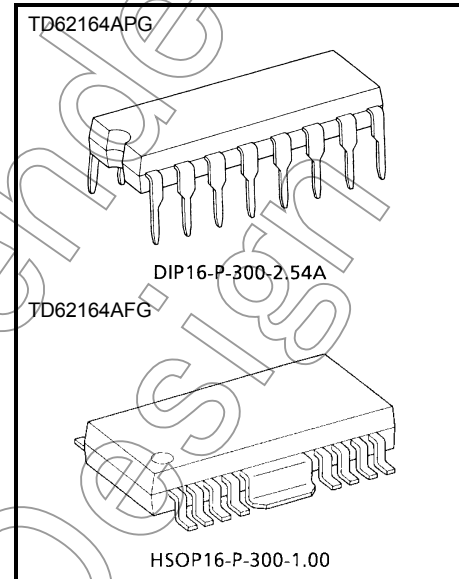
Applications include relay, hammer, lamp and stepping motor drivers.

Please observe the thermal condition for using.

The suffix (G) appended to the part number represents a Lead (Pb)-Free product.

Features

- Output current (single output) 700 mA (max)
- High sustaining voltage output 50 V (min)
- Output clamp diodes
- Input compatible with TTL and 5-V CMOS
- GND and SUB terminal heat sink
- Package type-APG: DIP-16 pin
- Package type-AFG: HSOP-16 pin



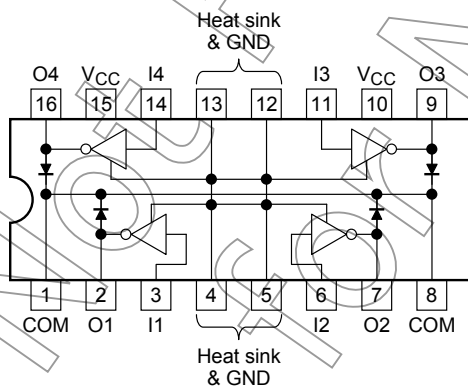
Weight

DIP16-P-300-2.54A : 1.11 g (typ.)

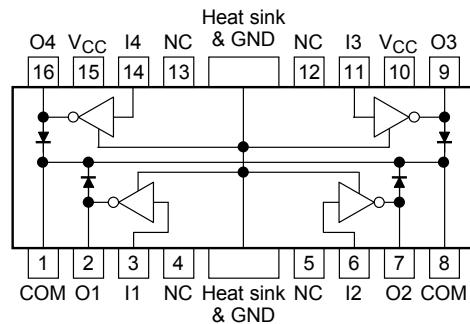
HSOP16-P-300-1.00 : 0.50 g (typ.)

Pin Connection (top view)

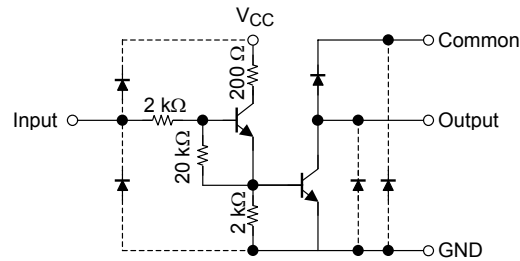
TD62164APG



TD62164AFG



Schematics (each driver)



Note: The input and output parasitic diodes cannot be used as clamp diodes.

Absolute Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Supply voltage	V _{CC}	-0.5 to 17	V
Output sustaining voltage	V _{CE (SUS)}	-0.5 to 50	V
Output current	I _{OUT}	700	mA/ch
Input current	I _{IN}	50	mA
Input voltage	V _{IN}	17	V
Clamp diode reverse voltage	V _R	50	V
Clamp diode forward current	I _F	700	mA
Operating temperature	APG	P _D	1.47/2.7 (Note 1)
	AFG		
Operating temperature	T _{opr}	-40 to 85	°C
Storage temperature	T _{stg}	-55 to 150	°C

Note 1: On glass epoxy PCB (50 × 50 × 1.6 mm Cu 50%)

Note 2: On glass epoxy PCB (60 × 60 × 1.6 mm Cu 30%)

Recommended Operating Conditions (Ta = -40 to 85°C)

Characteristics	Symbol	Condition	Min	Typ.	Max	Unit
Supply voltage	V _{CC}		4.5	—	5.5	V
Output sustaining voltage	V _{CE (SUS)}		0	—	50	V
Output current	I _{OUT}	DC 1 circuit, Ta = 25°C	0	—	570	mA/ch
		T _{pw} = 25 ms				
		Duty = 10%	0	—	570	
		4 circuits	0	—	570	
Input voltage	V _{IN}	Ta = 85°C	0	—	570	V
		T _j = 120°C	0	—	480	
		h _{FE} = 150	10.0	—	15	
		h _{FE} = 2000	2.4	—	15	
Input voltage	Output on	I _{OUT} = 500 mA	0	—	0.4	V
	Output off		0	—	0.4	
Input current	I _{IN}		0	—	20	mA
Clamp diode reverse voltage	V _R		—	—	50	V
Clamp diode forward current	I _F		—	—	500	mA
Power dissipation	APG	Ta = 85°C (Note 1)	—	—	1.4	W
	AFG	Ta = 85°C (Note 2)	—	—	0.7	

Note 1: On glass epoxy PCB (50 × 50 × 1.6 mm Cu 50%)

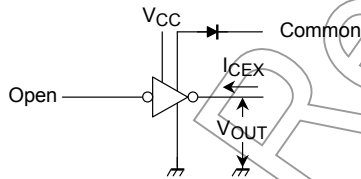
Note 2: On glass epoxy PCB (60 × 30 × 1.6 mm Cu 30%)

Electrical Characteristics (Ta = 25°C)

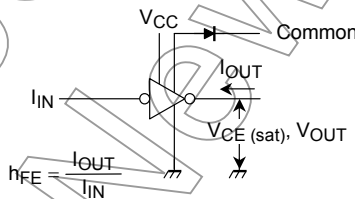
Characteristics	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Output leakage current	I_{CEX}	1	$V_{CE} = 50 \text{ V}, T_a = 25^\circ\text{C}$		—	50	μA
			$V_{CE} = 50 \text{ V}, T_a = 85^\circ\text{C}$		—	100	
Collector-emitter saturation voltage	$V_{CE(sat)}$	2	$I_{OUT} = 500 \text{ mA}, V_{CC} = 5 \text{ V}$		—	0.8	V
			$I_{OUT} = 200 \text{ mA}, V_{CC} = 5 \text{ V}$		—	0.45	
DC current transfer ratio	h_{FE}	2	$V_{CE} = 2 \text{ V}, I_{OUT} = 500 \text{ mA}$	2000	—	—	
Input voltage (Output on)	$V_{IN(ON)}$	3	$I_{OUT} = 500 \text{ mA}, h_{FE} = 150$	7.0	—	10.0	V
			$I_{OUT} = 500 \text{ mA}, h_{FE} = 2000$	1.8	—	2.4	
Clamp diode reverse current	I_R	4	$V_R = 50 \text{ V}, T_a = 25^\circ\text{C}$	—	—	50	μA
			$V_R = 50 \text{ V}, T_a = 85^\circ\text{C}$	—	—	100	
Clamp diode forward voltage	V_F	5	$I_F = 500 \text{ mA}$	—	—	2.0	V
Supply current	Output on	6	$V_{CC} = 5.5 \text{ V}, V_{IN} = 2.4 \text{ V}$	—	35	40	mA/ch
	Output off		$V_{CC} = 5.5 \text{ V}, V_{IN} = 0.4 \text{ V}$	—	—	10	
Input capacitance	C_{IN}		$V_{IN} = 0 \text{ V}, f = 1 \text{ MHz}$	—	15	—	pF
Turn-on delay	t_{ON}	7	$V_{OUT} = 50 \text{ V}, R_L = 72 \Omega$	—	0.2	0.4	μs
Turn-off delay	t_{OFF}		$V_{CC} = 5.0 \text{ V}, C_L = 15 \text{ pF}$	—	4.0	8.0	

Test Circuit

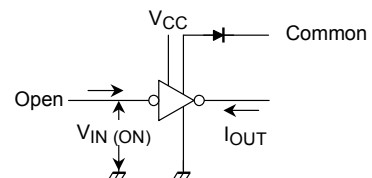
1. I_{CEX}



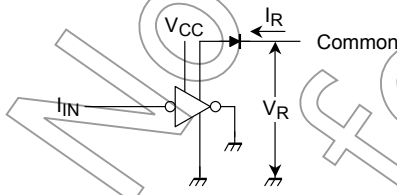
2. $h_{FE}, V_{CE(sat)}$



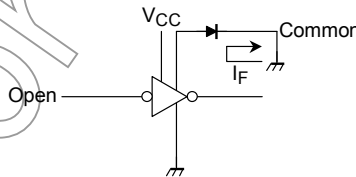
3. $V_{IN(ON)}$



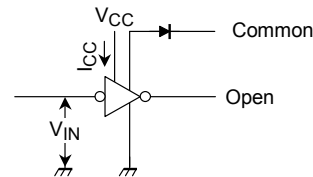
4. I_R



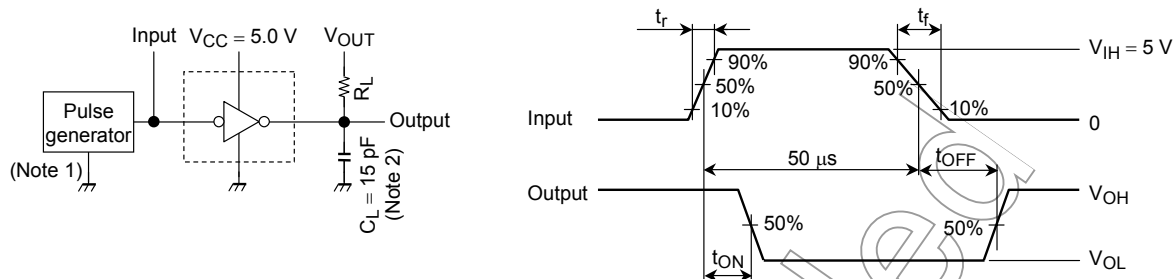
5. V_F



6. $I_{CC(ON)}, I_{CC(OFF)}$



7. t_{ON} , t_{OFF}



Note 1: Pulse width 50 μs , duty cycle 10%, output impedance 50 Ω , $t_r \leq 5 \text{ ns}$, $t_f \leq 10 \text{ ns}$.

Note 2: C_L includes probe and jig capacitance.

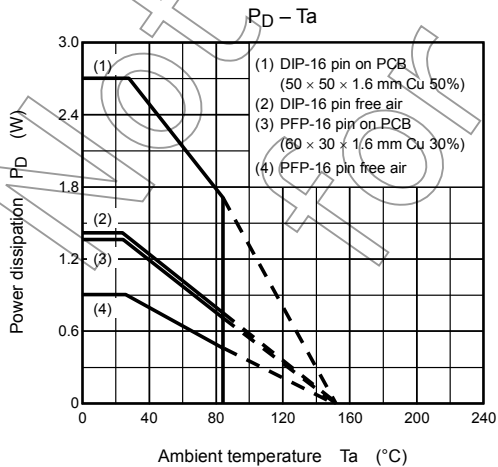
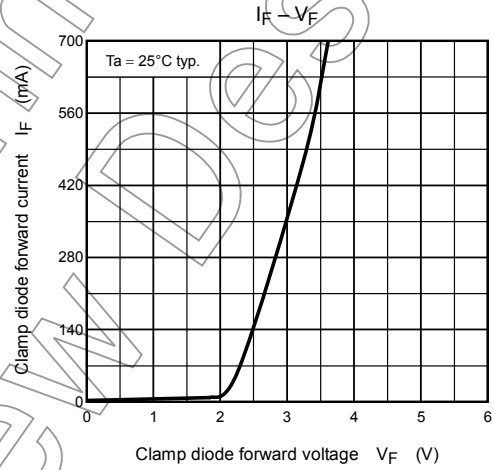
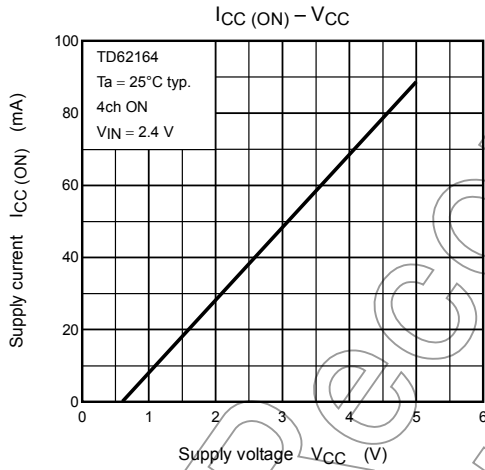
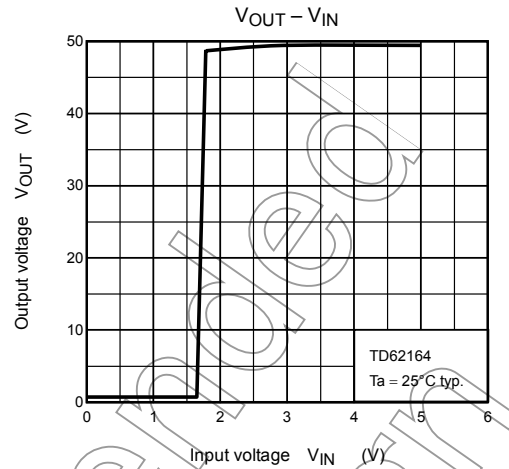
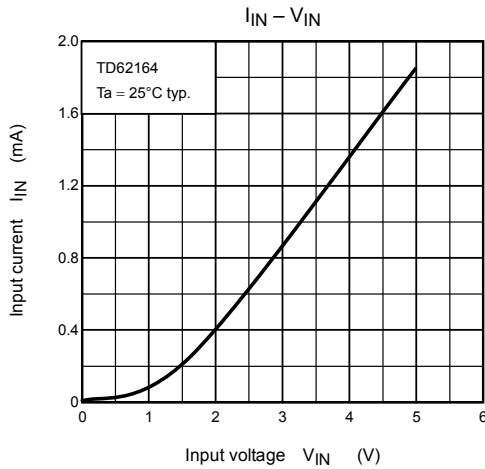
Precautions for Using

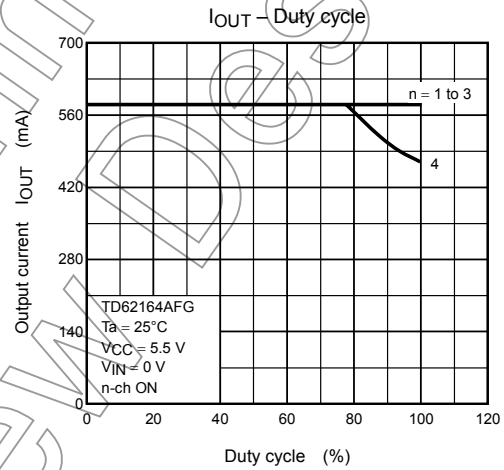
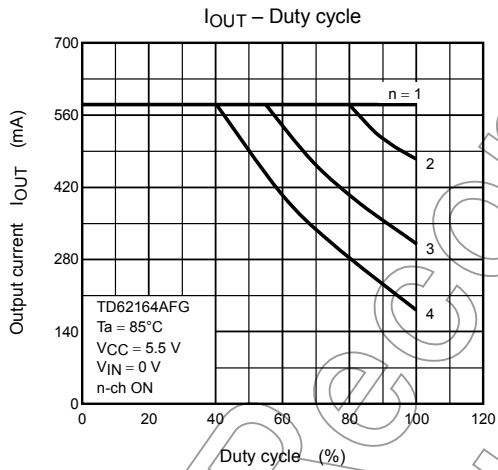
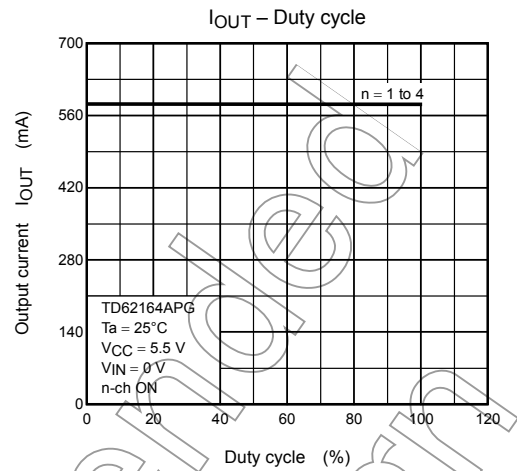
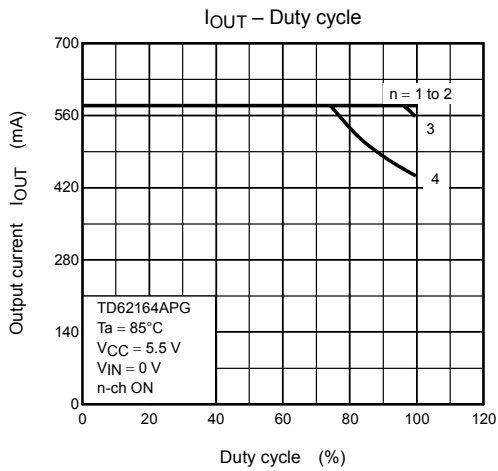
This IC does not include built-in protection circuits for excess current or overvoltage.

If this IC is subjected to excess current or overvoltage, it may be destroyed.

Hence, the utmost care must be taken when systems which incorporate this IC are designed.

Utmost care is necessary in the design of the output line, V_{CC} , COMMON and GND line since IC may be destroyed due to short-circuit between outputs, air contamination fault, or fault by improper grounding.



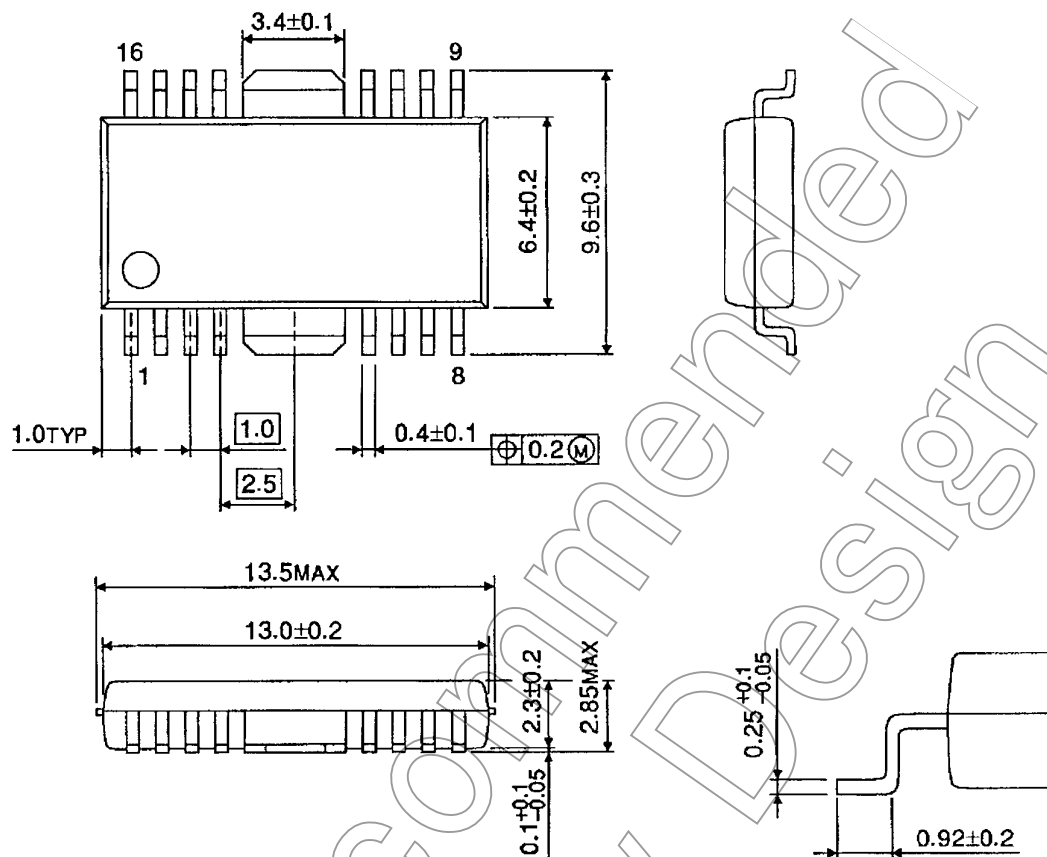


DIP16-P-300-2.54A

2006-06-13

HSOP16-P-300-1.00

Unit : mm



Weight: 0.50 g (typ.)

Notes on Contents

1. Equivalent Circuits

The equivalent circuit diagrams may be simplified or some parts of them may be omitted for explanatory purposes.

2. Test Circuits

Components in the test circuits are used only to obtain and confirm the device characteristics. These components and circuits are not guaranteed to prevent malfunction or failure from occurring in the application equipment.

IC Usage Considerations

Notes on Handling of ICs

- (1) The absolute maximum ratings of a semiconductor device are a set of ratings that must not be exceeded, even for a moment. Do not exceed any of these ratings.
Exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result in injury by explosion or combustion.
- (2) Use an appropriate power supply fuse to ensure that a large current does not continuously flow in case of over current and/or IC failure. The IC will fully break down when used under conditions that exceed its absolute maximum ratings, when the wiring is routed improperly or when an abnormal pulse noise occurs from the wiring or load, causing a large current to continuously flow and the breakdown can lead smoke or ignition. To minimize the effects of the flow of a large current in case of breakdown, appropriate settings, such as fuse capacity, fusing time and insertion circuit location, are required.
- (3) If your design includes an inductive load such as a motor coil, incorporate a protection circuit into the design to prevent device malfunction or breakdown caused by the current resulting from the inrush current at power ON or the negative current resulting from the back electromotive force at power OFF. IC breakdown may cause injury, smoke or ignition.
Use a stable power supply with ICs with built-in protection functions. If the power supply is unstable, the protection function may not operate, causing IC breakdown. IC breakdown may cause injury, smoke or ignition.
- (4) Do not insert devices in the wrong orientation or incorrectly.
Make sure that the positive and negative terminals of power supplies are connected properly. Otherwise, the current or power consumption may exceed the absolute maximum rating, and exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result in injury by explosion or combustion.
In addition, do not use any device that is applied the current with inserting in the wrong orientation or incorrectly even just one time.
- (5) Carefully select external components (such as inputs and negative feedback capacitors) and load components (such as speakers), for example, power amp and regulator.
If there is a large amount of leakage current such as input or negative feedback condenser, the IC output DC voltage will increase. If this output voltage is connected to a speaker with low input withstand voltage, overcurrent or IC failure can cause smoke or ignition. (The over current can cause smoke or ignition from the IC itself.) In particular, please pay attention when using a Bridge Tied Load (BTL) connection type IC that inputs output DC voltage to a speaker directly.

Points to Remember on Handling of ICs**(1) Heat Radiation Design**

In using an IC with large current flow such as power amp, regulator or driver, please design the device so that heat is appropriately radiated, not to exceed the specified junction temperature (T_j) at any time and condition. These ICs generate heat even during normal use. An inadequate IC heat radiation design can lead to decrease in IC life, deterioration of IC characteristics or IC breakdown. In addition, please design the device taking into consideration the effect of IC heat radiation with peripheral components.

(2) Back-EMF

When a motor rotates in the reverse direction, stops or slows down abruptly, a current flow back to the motor's power supply due to the effect of back-EMF. If the current sink capability of the power supply is small, the device's motor power supply and output pins might be exposed to conditions beyond absolute maximum ratings. To avoid this problem, take the effect of back-EMF into consideration in system design.

Not Recommended
for New Design

About solderability, following conditions were confirmed

- Solderability

- (1) Use of Sn-37Pb solder Bath

- solder bath temperature = 230°C
 - dipping time = 5 seconds
 - the number of times = once
 - use of R-type flux

- (2) Use of Sn-3.0Ag-0.5Cu solder Bath

- solder bath temperature = 245°C
 - dipping time = 5 seconds
 - the number of times = once
 - use of R-type flux

RESTRICTIONS ON PRODUCT USE

060116EBA

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